

L Number	Hits	Search Text	DB	Time stamp
4	5	("5500588"   "5543728"   "5608329"   "5696773"   "5760599").PN.	USPAT	2004/08/14 15:23
-	0	test\$4 with semiconductor same gradation near voltage	USPAT	2004/08/14 12:08
-	4936	(test\$4 with semiconductor).ti,ab,clm.	USPAT	2004/08/14 11:23
-	16712	gradation	USPAT	2004/08/14 11:28
-	11	((test\$4 with semiconductor).ti,ab,clm.) and gradation	USPAT	2004/08/14 11:24
-	124510	compar\$4 and correction	USPAT	2004/08/14 11:25
-	213	((test\$4 with semiconductor).ti,ab,clm.) and (compar\$4 and correction)	USPAT	2004/08/14 12:50
-	225	gradation near voltage	USPAT	2004/08/14 11:28
-	0	((test\$4 with semiconductor).ti,ab,clm.) and (gradation near voltage)	USPAT	2004/08/14 11:28
-	0	test\$4 with (gradation near voltage)	USPAT	2004/08/14 12:33
-	0	correct\$4 with intrinsic adj error	USPAT	2004/08/14 12:34
-	0	intrinsic adj error	USPAT	2004/08/14 12:35
-	503	grad\$4 adj voltage	USPAT	2004/08/14 12:36
-	2	((test\$4 with semiconductor).ti,ab,clm.) and (grad\$4 adj voltage)	USPAT	2004/08/14 12:36
-	1	5623215.URPN.	USPAT	2004/08/14 12:37
-	263	toshiba.as. and hashizume.in.	USPAT; US-PGPUB; JPO	2004/08/14 12:50
-	0	((test\$4 with semiconductor).ti,ab,clm.) and (toshiba.as. and hashizume.in.)	USPAT; US-PGPUB; JPO	2004/08/14 12:50
-	7239	comparator and test\$4 with voltage	USPAT; US-PGPUB; JPO	2004/08/14 12:51
-	1	(toshiba.as. and hashizume.in.) and (comparator and test\$4 with voltage)	USPAT; US-PGPUB; JPO	2004/08/14 12:52
-	1	"60259018"	USPAT; US-PGPUB; JPO	2004/08/14 12:56
-	3483	test\$4 with output near voltage	USPAT; US-PGPUB; JPO	2004/08/14 12:57
-	292	(compar\$4 and correction) and (test\$4 with output near voltage)	USPAT; US-PGPUB; JPO	2004/08/14 12:57